Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination	Applicant(s)/Patent under Reexamination	
10/709,074	TSAI, CHIEH-CHIH	TSAI, CHIEH-CHIH	
Examiner	Art Unit		
Fayyaz Alam	2618		

	0545	01155	
	SEAR	CHED	
Class	Subclass	Date	Examiner
455	41.2	11/2/2006	FA
455	513	11/2/2006	FA
455	456.1	11/2/2006	FA

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
		· · · · · · · · · · · · · · · · · · ·		
	1			
		• 		

	SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR		
EAST Image and keyword search in USPAT, US-PGPUB, USOCR, JPO, EPO, DERWENT, IBM_TDB	11/2/2006	FA		
•				
		·		